1F1X SERIES PHOTOFLASH FAST RECOVERY RECTIFIER

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1F10 THRU 1F18

PHOTOFLASH FAST RECOVERY RECTIFIER



REVERSE VOLTAGE: 1000 to 1800 VOLTS FORWARD CURRENT: 0.5 AMPERE

FEATURES

· Fast switching

· Low leakage

· Low forward voltage drop

· High current capability

· High current surge

· High reliability

MECHANICAL DATA

Case: Molded plastic, R-1

Epoxy: UL 94V-O rate flame retardant

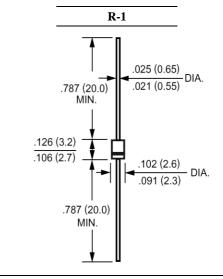
Lead: Axial leads, solderable per MIL-STD-202,

method 208 guaranteed

Polarity: Color band denotes cathode end

Mounting position: Any

Weight: 0.0064ounce, 0.181gram



Dimensions in inches and (millimeters)

Maximum Ratings and Electrical Characteristics

Ratings at 25 ambient temperature unless otherwise specified.

Single phase, half wave, 60Hz, resistive or inductive load.

For capacitive load, derate current by 20%.

	Symbols	1F10	1F12	1F14	1F15	1F16	1F18	Units
Maximum Recurrent Peak Reverse Voltage	V_{RRM}	1000	1200	1400	1500	1600	1800	Volts
Maximum RMS Voltage	V_{RMS}	700	840	980	1050	1120	1260	Volts
Maximum DC Blocking Voltage	V_{DC}	1000	1200	1400	1500	1600	1800	Volts
Maximum Average Forward Rectified Current	Ţ	0.5						Amp
at T _A =25	$I_{(AV)}$							
Peak Forward Surge Current,								
8.3ms single half-sine-wave	I_{FSM} 25							Amp
superimposed on rated load (JEDEC method)								
Maximum Forward Voltage	$\mathbf{V_F}$	1.8						Volts
at 0.5A DC and 25	v _F							
Maximum Reverse Current		5.0						uAmp
at Rated DC Blocking Voltage T _A =25	I_{R}							
Maximum Full Load Reverse Current Average,	I R	100						uAmp
Full Cycle .375", (9.5mm) lead length at $T_L = 55$								
Typical Junction Capacitance (Note 1)	C_{J}	15						pF
Maximum Reverse Recovery Time (Note 2)	T_{RR}	300						nS
Operating and Storage Temperature Range	T _J , Tstg	-55 to +150						

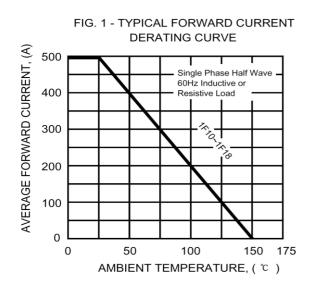
NOTES:

- 1- Measured at 1 MHz and applied reverse voltage of 4.0 VDC.
- 2- Reverse Recovery Test Conditions : $I_F \!\!=\! .5A$, $I_R \!\!=\! 1A$, $I_{RR} \!\!=\! .25A$.





RATINGS AND CHARACTERISTIC CURVES



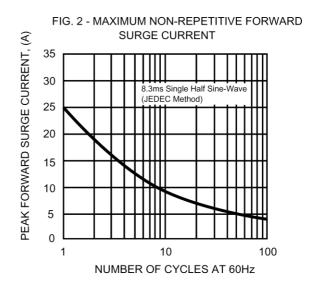


FIG. 3 - TEST CIRCUIT DIAGRAM AND REVERSE RECOVERY TIME CHARACTERISTIC

